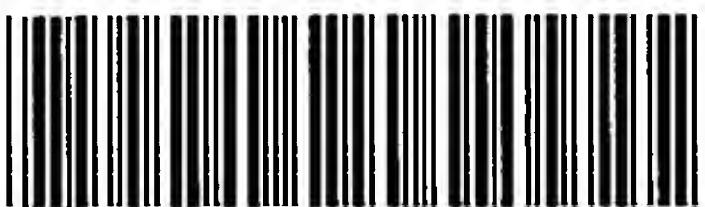


Search Notes



Application/Control No.

10/605,427

Examiner

Henry K. Choe

**Applicant(s)/Patent under
Reexamination**

YEH, EN-HSIANG

Art Unit

2817

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Text search (East)	3/28/05 H-C	
NPL (IEEE)	"	"

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner